

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10586319	INOUE, MIKIO
Examiner	Art Unit	
	CHARLES HICKS	4175

SEARCHED			
Class	Subclass	Date	Examiner
345	156-204	04/06/2009	CH
709	203-247	04/06/2009	CH
Above updated		10/02/2009	CH
Above updated		3/17/2010	CH
Above updated		11/04/2010	CH
Above updated		04/14/2011	CH
345	204	7/20/2011 (updated 12/16/2011)	CH

SEARCH NOTES			
Search Notes	Date	Examiner	
Inventor Search	04/06/2009	CH	
East Search	04/06/2009	CH	
Above updated	10/02/2009	CH	
Above updated	3/17/2010	CH	
Above updated	11/04/2010	CH	
Above updated	04/14/2011	CH	
345/204 (text search only - see search history printout)	7/20/2011 (updated 12/16/2011)	CH	
EAST (US PGPUB; US PAT; USOCR; EPO; JPO; DERWENT; IBM_TDB - text search only - see search history printout)	7/20/2011 (updated 12/16/2011)	CH	

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner